Notice of References Cited Application/Control No. 10/665,751 Examiner Julian D. Huffman Applicant(s)/Patent Under Reexamination RUTLAND ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,357,845 B1	03-2002	Kuwabara et al.	347/3
	В	US-6,464,349 B2	10-2002	Moriyama et al.	347/101
	С	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-		·	
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 62220940	03-1989	Japan	Murakami et al.	B41J 3/04
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

	TOTAL POSSIBLE OF THE POSSIBLE							
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	U							
	V							
	w							
	х							

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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